

## General Description

The WSF55P06 is the highest performance trench P-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSF55P06 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

## Features

- 100% UIS Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

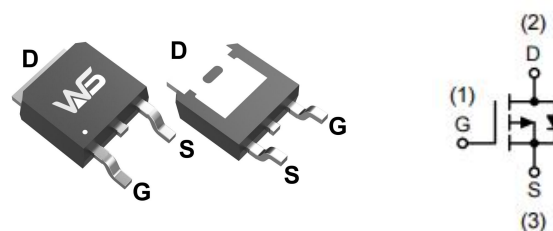
## Product Summary

$BV_{DSS}$	$R_{DS(ON)}$	$I_D$
-60V	20mΩ	-55A

## Applications

- Power Management for Industrial DC/DC Converters
- Ideal for high-frequency switching and synchronous rectification

## TO-252-2L Pin Configuration



## Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ , Unless Otherwise Noted)

Symbol	Parameter		Rating	Units
$V_{DS}$	Drain-Source Voltage		-60	V
$V_{GS}$	Gate-Source Voltage		$\pm 20$	
$I_D$ <sup>7</sup>	Continuous Drain Current	$T_C=25^\circ\text{C}$	-55	A
		$T_C=100^\circ\text{C}$	-32	
$I_{DM}$ <sup>3</sup>	Pulse Drain Current		-140	
$P_D$ <sup>2</sup>	Power Dissipation	$T_C=25^\circ\text{C}$	87	W
$I_{AS}$ <sup>3</sup>	Single pulse Avalanche Current		-62	A
$E_{AS}$ <sup>3</sup>	Single pulse Avalanche Energy	$L=0.5\text{mH}$	126	mJ
$T_{STG}$	Storage Temperature Range		-55 to 150	$^\circ\text{C}$
$T_J$	Operating Junction Temperature Range		-55 to 150	
$R_{\theta JA}$ <sup>1,4</sup>	Thermal Resistance-Junction to Ambient	$t \leq 10\text{s}$	31	$^\circ\text{C/W}$
		Steady State	62.5	
$R_{\theta JC}$	Thermal Resistance-Junction to Case		1.43	

**Electrical Characteristics ( $T_J=25^{\circ}\text{C}$ , Unless Otherwise Noted)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}$ , $I_D=-250\mu\text{A}$	-60	---	---	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=-10\text{V}$ , $I_D=-20\text{A}$	---	20	23	m $\Omega$
		$T_J=125^{\circ}\text{C}$	---	36	---	
		$V_{GS}=-4.5\text{V}$ , $I_D=-15\text{A}$	---	23	32	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=-250\mu\text{A}$	-1.0	-1.5	-2.2	V
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=-60\text{V}$ , $V_{GS}=0\text{V}$	---	---	-1.0	$\mu\text{A}$
		$T_J=55^{\circ}\text{C}$	---	---	-5.0	
$I_{GSS}$	Gate-Source Leakage Current	$V_{DS}=0\text{V}$ , $V_{GS}=\pm 10\text{V}$	---	---	$\pm 100$	nA
$g_{fs}$	Forward Transconductance	$V_{DS}=-5\text{V}$ , $I_D=-20\text{A}$	---	48	---	S
$R_G$	Gate Resistance	$f=1.0\text{MHz}$	---	16	---	$\Omega$
$Q_g$	Total Gate Charge (10V)	$V_{DS}=-40\text{V}$ , $V_{GS}=-10\text{V}$ , $I_D=-20\text{A}$	---	61	---	nC
$Q_{gs}$	Gate-Source Charge		---	5	---	
$Q_{gd}$	Gate-Drain Charge		---	18	---	
$T_{d(on)}$	Turn-On Delay Time	$V_{DD}=-40\text{V}$ , $V_{GS}=-10\text{V}$ , $I_D=-20\text{A}$ $R_L=1\Omega$ , $R_{GEN}=3\Omega$	---	11	---	ns
$T_r$	Rise Time		---	56	---	
$T_{d(off)}$	Turn-Off Delay Time		---	119	---	
$T_f$	Fall Time		---	58	---	
$C_{iss}$	Input Capacitance	$V_{DS}=-25\text{V}$ , $V_{GS}=0\text{V}$ , $f=1.0\text{MHz}$	---	2750	---	pF
$C_{oss}$	Output Capacitance		---	220	---	
$C_{rss}$	Reverse Transfer Capacitance		---	198	---	

**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
$I_S$ <sup>7</sup>	Continuous Source Current		---	---	-55	A
$V_{SD}$	Diode Forward Voltage	$V_{GS}=0\text{V}$ , $I_S=-1\text{A}$	---	---	-1.4	V
$t_{rr}$	Reverse Recovery Time	$I_F=-20\text{A}$ , $di/dt=500\text{A}/\mu\text{s}$	---	21	---	ns
$Q_{rr}$	Reverse Recovery Charge		---	1.3	---	nC

Note:

- The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design.
- The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- Single pulse width limited by junction temperature  $T_{J(MAX)}=150^{\circ}\text{C}$ .
- The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.
- These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=150^{\circ}\text{C}$ . The SOA curve provides a single pulse rating.
- The maximum current rating is package limited.
- These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ .
- The maximum current rating is silicon limited

## Typical Characteristics

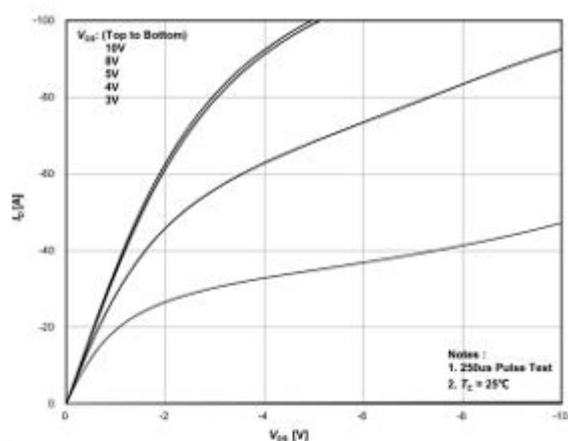


Figure 1. On-Region Characteristics

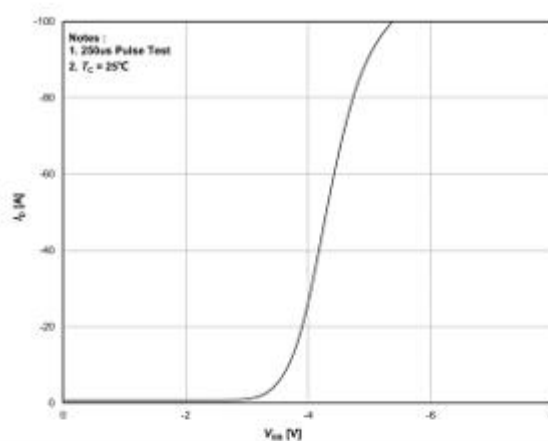


Figure 2. Transfer Characteristics

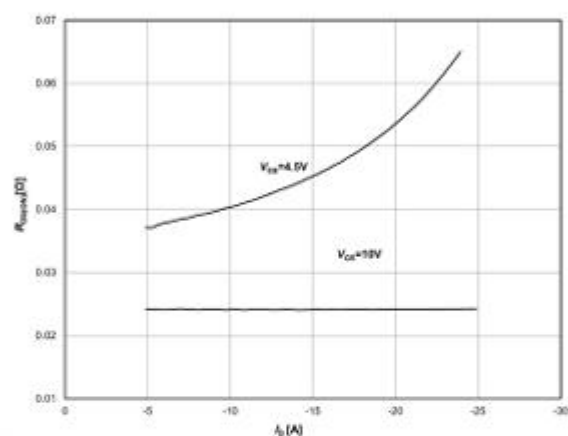


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

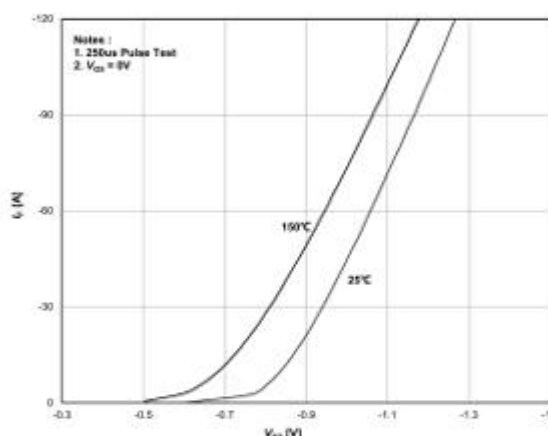


Figure 4. Body Diode Forward Voltage Variation with Current

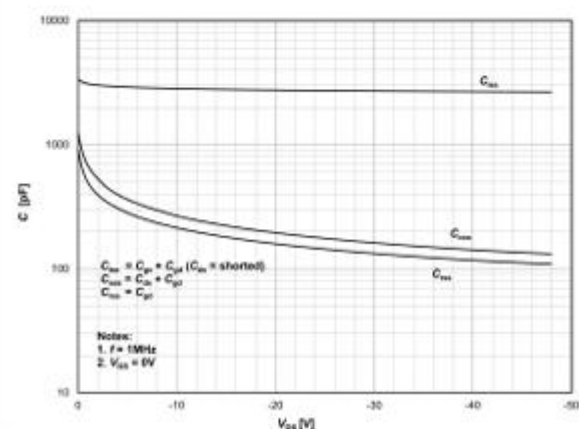


Figure 5. Capacitance Characteristics

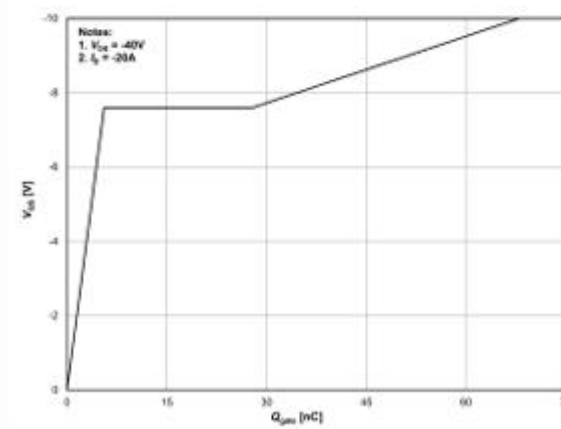
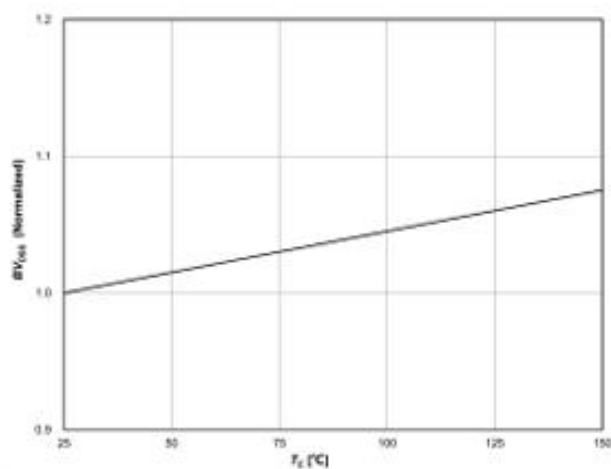
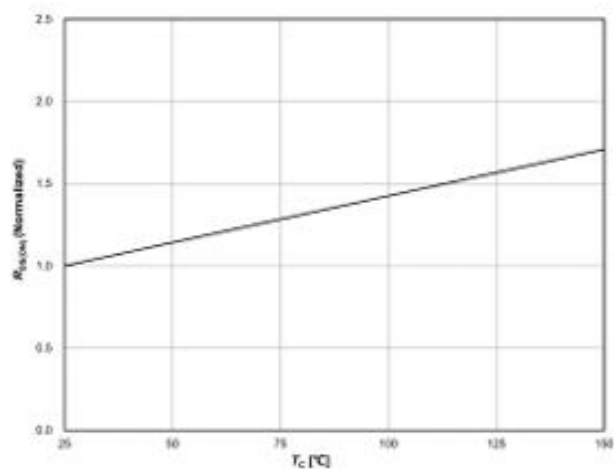


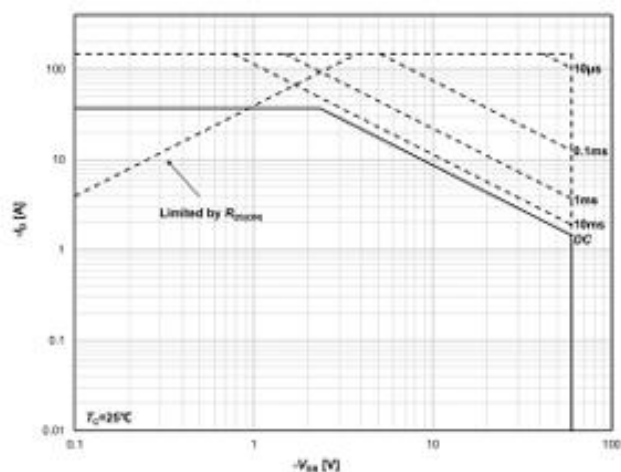
Figure 6. Gate Charge Characteristics



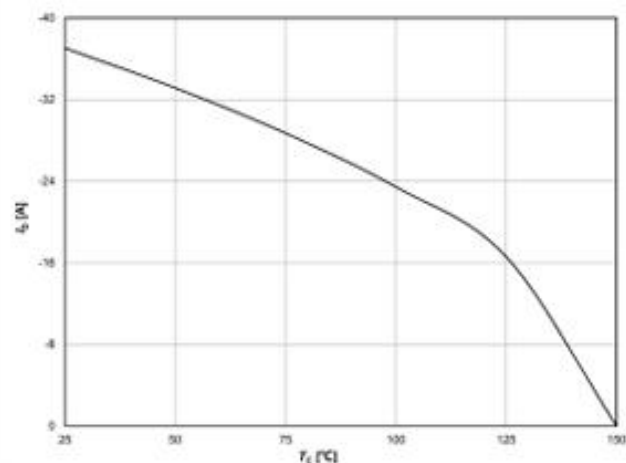
**Figure 7. Breakdown Voltage Variation vs Temperature**



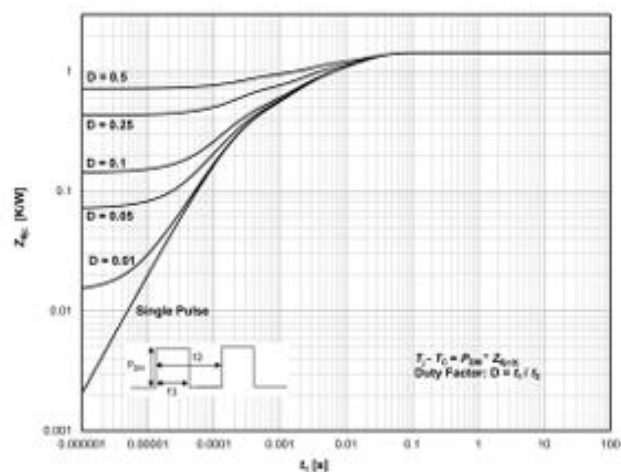
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area<sup>3)</sup>**

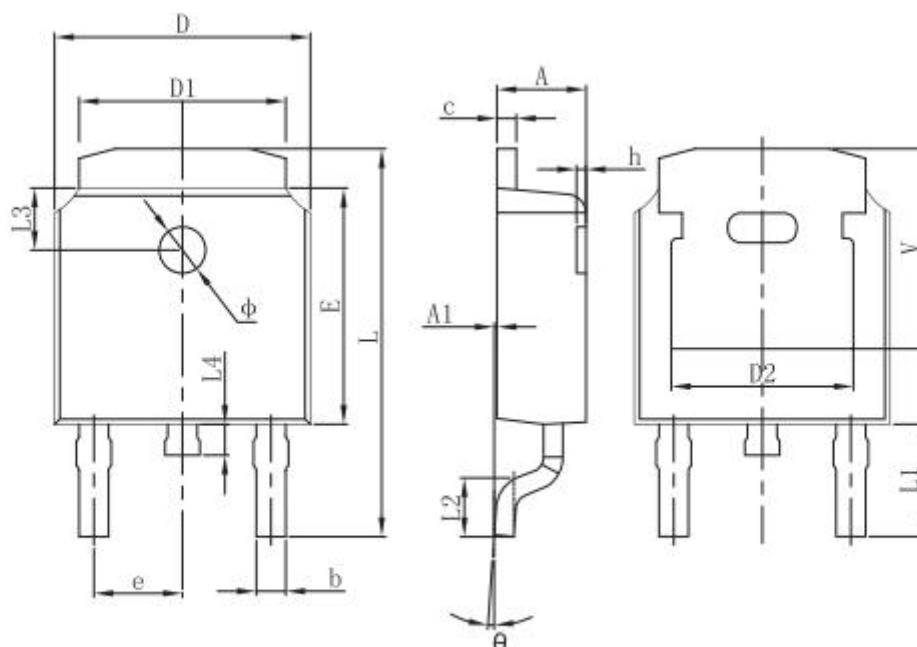


**Figure 10. Maximum Drain Current vs Case Temperature**



**Figure 11. Transient Thermal Response Curve**

## Packaging information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.635	0.770	0.025	0.030
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 REF.		0.190 REF.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.712	10.312	0.382	0.406
L1	2.900 REF.		0.114 REF.	
L2	1.400	1.700	0.055	0.067
L3	1.600 REF.		0.063 REF.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.250 REF.		0.207 REF.	

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